

1. Product profile

1.1 General description

500 W GaN packaged asymmetric Doherty power transistor for base station applications at frequencies from 1800 MHz to 2000 MHz.

Table 1. Typical performance

Typical RF performance at $T_{case} = 25\text{ °C}$ in an asymmetrical Doherty application demo circuit.
 $V_{DS} = 48\text{ V}$; $I_{Dq} = 350\text{ mA}$ (main), $V_{GS(amp)peak} = -4.8\text{ V}$, unless otherwise specified.

Test signal	f	I_{Dq}	V_{DS}	$P_{L(AV)}$	G_p	η_D	ACPR	$P_{L(5dB)}$
	(MHz)	(mA)	(V)	(dBm)	(dB)	(%)	(dBc)	(dBm)
1-carrier W-CDMA [1]	1805 to 1880	350	48	49.2	15.0	59.0	-31.0	-
pulsed CW [2]	1805 to 1880	350	48	-	-	-	-	57.0

[1] Test signal: 1-carrier W-CDMA; 3GPP test model 1; 64 DPCH; PAR = 10.5 dB at 0.01 % probability on CCDF.

[2] Test signal: pulsed CW; $t_p = 30\text{ }\mu\text{s}$; $\delta = 35\text{ }\%$.

1.2 Features and benefits

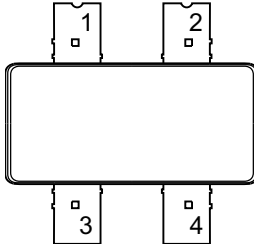
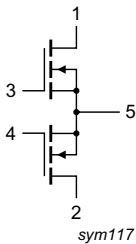
- Excellent digital pre-distortion capability
- High efficiency
- Designed for broadband operation
- Lower output capacitance for improved performance in Doherty applications
- Internally matched for ease of use

1.3 Applications

- RF power amplifier for base stations and multi carrier applications in the 1800 MHz to 2000 MHz frequency range

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	drain1 (main)		
2	drain2 (peak)		
3	gate1 (main)		
4	gate2 (peak)		
5	source ^[1]		

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Package name	Orderable part number	12NC	Packing description	Min. orderable quantity (pieces)
SOT1273-1	C4H18W500AZ	9349 604 86517	Tray; 20-fold; dry pack	60
	C4H18W500AY	9349 604 86518	TR13; 100-fold; 44 mm; dry pack	100

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DD}	supply voltage	operating	-	52	V
V_{DS}	drain-source voltage	$V_{GS} = -8$ V	-	150	V
$V_{GS(amp)main}$	main amplifier gate-source voltage		-15	+2	V
$V_{GS(amp)peak}$	peak amplifier gate-source voltage		-15	+2	V
$I_{GF(amp)main}$	main amplifier forward gate current		-	24	mA
$I_{GF(amp)peak}$	peak amplifier forward gate current		-	40	mA
T_{stg}	storage temperature		-65	+150	°C
T_{ch}	active die channel temperature	^[1]	-	275	°C
T_{case}	case temperature	operating ^[1]	-40	+130	°C

[1] Continuous use at maximum temperature will affect the reliability, for details refer to the online MTF calculator.

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(s-c)(IR)}$ [1][3]	thermal resistance from active die surface to case by Infrared measurement	$V_{DS} = 48\text{ V}$; $I_{DQ} = 250\text{ mA}$; $V_{GS(amp)peak} = -5\text{ V}$; $T_{case} = 80\text{ °C}$; CW; $P_L = 80\text{ W}$; $P_{dis} = 62\text{ W}$	0.77	K/W
$R_{th(ch-c)(FEA)}$ [2][3][4]	thermal resistance from active die channel to case by Finite Element Analysis	$T_{case} = 81\text{ °C}$; $P_{dis} = 65\text{ W}$	1.44	K/W

[1] Infrared (IR) thermal values are for reference only and cannot be used to determine performance or reliability.

[2] Finite Element Analysis (FEA) thermal values have been used for the online MTF calculator.

[3] P_{dis} is total Doherty dissipation power which includes main and peak amplifier.

[4] Peak amplifier is assumed to contribute 10 % Doherty dissipation power.

6. Characteristics

Table 6. DC characteristics

$T_j = 25\text{ °C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Main device						
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10\text{ V}$; $I_D = 24\text{ mA}$	-3.30	-2.65	-2.00	V
V_{GSQ}	gate-source quiescent voltage	$V_{DS} = 50\text{ V}$; $I_D = 480\text{ mA}$	-3.30	-2.65	-2.00	V
$I_{D(leak)}$	drain leakage current	$V_{GS} = -10\text{ V}$; $V_{DS} = 50\text{ V}$	-	-	5.81	mA
I_{GSS}	gate leakage current	$V_{GS} = -8\text{ V}$; $V_{DS} = 0\text{ V}$	-	-	1.16	mA
Peak device						
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10\text{ V}$; $I_D = 40\text{ mA}$	-2.80	-2.15	-1.50	V
V_{GSQ}	gate-source quiescent voltage	$V_{DS} = 50\text{ V}$; $I_D = 800\text{ mA}$	-2.80	-2.15	-1.50	V
$I_{D(leak)}$	drain leakage current	$V_{GS} = -10\text{ V}$; $V_{DS} = 50\text{ V}$	-	-	9.68	mA
I_{GSS}	gate leakage current	$V_{GS} = -8\text{ V}$; $V_{DS} = 0\text{ V}$	-	-	2.42	mA

Table 7. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 7.2 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 64 DPCH; $f_1 = 1807.5\text{ MHz}$; $f_2 = 1877.5\text{ MHz}$; RF performance at $V_{DS} = 48\text{ V}$; $I_{DQ} = 250\text{ mA}$; $V_{GS(amp)peak} = -5.0\text{ V}$ (typical); $T_{case} = 25\text{ °C}$; unless otherwise specified; in a Doherty production RF test circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
G_p	power gain	$P_{L(AV)} = 83.2\text{ W}$	13.6	14.6	-	dB
η_D	drain efficiency	$P_{L(AV)} = 83.2\text{ W}$	50.5	56.0	-	%
RL_{in}	input return loss	$P_{L(AV)} = 83.2\text{ W}$	-	-16	-8	dB
ACPR	adjacent channel power ratio	$P_{L(AV)} = 83.2\text{ W}$	-	-32.0	-28.0	dBc

Table 8. RF characteristics

Test signal: pulsed CW; $t_p = 100\text{ }\mu\text{s}$; $\delta = 10\%$; $f = 1880\text{ MHz}$; RF performance at $V_{DS} = 48\text{ V}$; $I_{DQ} = 250\text{ mA}$; $V_{GS(amp)peak} = -5.0\text{ V}$ (typical); $T_{case} = 25\text{ °C}$; unless otherwise specified; in a Doherty production RF test circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$P_{L(3dB)}$	output power at 3 dB gain compression	-	335	410	-	W

7. Test information

7.1 Ruggedness in Doherty operation

The C4H18W500A is capable of withstanding a load mismatch corresponding to $V_{SWR} = 10 : 1$ through all phases under the following conditions: $V_{DS} = 52 \text{ V}$; $I_{DQ} = 250 \text{ mA}$; $V_{GS(amp)peak} = -5.0 \text{ V}$; $P_L = 550 \text{ W}$ (pulsed CW; $t_p = 100 \mu\text{s}$; $\delta = 10 \%$); $f = 1805 \text{ MHz}$; tested on the Doherty development RF test circuit.

7.2 Impedance information

Table 9. Typical impedance of maximum power and drain efficiency

Measured load-pull data (main device); all data measured on a harmonic impedance non-optimized load-pull fixture; $I_{DQ} = 550 \text{ mA}$; $V_{DS} = 48 \text{ V}$; test signal: pulsed CW; $t_p = 100 \mu\text{s}$; $\delta = 10 \%$; typical values unless otherwise specified.

f	Z_S [1]	Z_L [1]	P_L [2]	P_L [2]	η_D [2]	G_p [2]	AM/PM [2]
(MHz)	(Ω)	(Ω)	(dBm)	(W)	(%)	(dB)	($^\circ$)
Maximum power load							
1805	4.6 – j11.0	3.3 – j0.8	53.8	240	70.9	15.3	–12
1842	5.0 – j11.8	3.0 – j1.8	53.9	247	65.4	14.7	–9
1880	5.9 – j12.4	3.2 – j2.0	53.9	248	66.3	14.9	–10
1930	7.4 – j13.6	3.0 – j2.1	54.0	250	64.8	14.7	–11
1960	8.7 – j14.1	2.9 – j2.3	54.0	249	64.3	14.8	–11
1990	9.7 – j14.3	2.9 – j2.2	54.0	249	66.2	14.8	–12
Maximum drain efficiency load							
1805	4.6 – j11.0	3.2 + j1.1	52.4	172	77.4	16.4	–21
1842	5.0 – j11.8	2.5 + j1.1	52.0	158	78.6	17.2	–24
1880	5.9 – j12.4	2.6 + j1.0	51.9	154	78.8	17.4	–23
1930	7.4 – j13.6	2.4 + j0.7	52.0	157	77.5	17.1	–27
1960	8.7 – j14.1	2.4 + j0.6	51.9	154	77.7	17.1	–29
1990	9.7 – j14.3	2.4 – j0.2	52.7	186	76.9	16.6	–26

[1] Z_S and Z_L defined in [Figure 1](#).

[2] At 3 dB gain compression.

Table 10. Typical impedance of maximum power and drain efficiency

Measured load-pull data (peak device); all data measured on a harmonic impedance non-optimized load-pull fixture; $I_{DQ} = 780 \text{ mA}$; $V_{DS} = 48 \text{ V}$; test signal: pulsed CW; $t_p = 100 \mu\text{s}$; $\delta = 10 \%$; typical values unless otherwise specified.

f	Z_S [1]	Z_L [1]	P_L [2]	P_L [2]	η_D [2]	G_p [2]	AM/PM [2]
(MHz)	(Ω)	(Ω)	(dBm)	(W)	(%)	(dB)	($^\circ$)
Maximum power load							
1805	4.8 – j8.8	1.5 – j1.5	56.3	422	63.0	14.1	–7
1842	5.6 – j9.5	1.5 – j1.5	56.3	424	66.6	14.5	–9
1880	6.8 – j9.7	1.6 – j1.7	56.3	426	66.9	14.5	–9
1930	9.3 – j8.4	1.7 – j1.9	56.0	402	67.1	15.1	–9
1960	10.3 – j7.7	1.7 – j2.1	55.9	392	66.3	15.2	–9

Table 10. Typical impedance of maximum power and drain efficiency ...continued

Measured load-pull data (peak device); all data measured on a harmonic impedance non-optimized load-pull fixture; $I_{DQ} = 780$ mA; $V_{DS} = 48$ V; test signal: pulsed CW; $t_p = 100$ μ s; $\delta = 10$ %; typical values unless otherwise specified.

f	Z_S [1]	Z_L [1]	P_L [2]	P_L [2]	η_D [2]	G_p [2]	AM/PM [2]
(MHz)	(Ω)	(Ω)	(dBm)	(W)	(%)	(dB)	($^\circ$)
1990	10.9 – j6.9	1.6 – j2.0	55.9	387	68.4	15.4	–11
Maximum drain efficiency load							
1805	4.8 – j8.8	1.9 – j0.2	54.8	300	72.6	16.0	–19
1842	5.6 – j9.5	1.4 + j0.0	53.7	234	72.7	16.3	–26
1880	6.8 – j9.7	1.4 – j0.1	53.8	238	73.3	16.2	–25
1930	9.3 – j8.4	1.7 – j0.9	54.8	305	74.6	16.7	–21
1960	10.3 – j7.7	1.7 – j1.0	54.7	292	74.2	16.6	–20
1990	10.9 – j6.9	1.6 – j1.0	54.1	259	73.9	16.8	–22

[1] Z_S and Z_L defined in [Figure 1](#).

[2] At 3 dB gain compression.

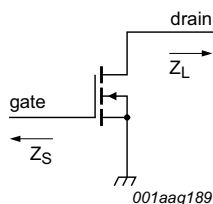


Fig 1. Definition of transistor impedance

7.3 Recommended impedances for Doherty design

Table 11. Typical impedance of main device at 1 : 1 load

Measured load-pull data (main device); $I_{DQ} = 550$ mA; $V_{DS} = 48$ V; pulsed CW ($t_p = 100$ μ s; $\delta = 10$ %).

f	Z_S [1]	Z_L [1]	P_L [2]	η_D [2]	G_p [2]	AM/PM [2]
(MHz)	(Ω)	(Ω)	(W)	(%)	(dB)	($^\circ$)
1805	4.6 – j11.0	3.3 – j0.4	228	73.5	15.6	–15
1842	5.0 – j11.8	3.1 – j0.5	233	75.2	15.8	–14
1880	5.9 – j12.4	3.1 – j0.7	234	75.1	15.9	–14
1930	7.4 – j13.6	2.8 – j0.8	238	74.2	15.8	–17
1960	8.7 – j14.1	2.6 – j0.9	236	74.6	15.9	–17
1990	9.7 – j14.3	3.0 – j1.3	234	72.1	15.7	–17

[1] Z_S and Z_L defined in [Figure 1](#).

[2] At 3 dB gain compression.

Table 12. Typical impedance of main device at 1 : 1.5 load

Measured load-pull data (main device); $I_{DQ} = 550 \text{ mA}$; $V_{DS} = 48 \text{ V}$; pulsed CW ($t_p = 100 \mu\text{s}$; $\delta = 10 \%$).

f	Z_S [1]	Z_L [1]	P_L [2]	η_D [3]	G_p [3]	AM/PM [2]
(MHz)	(Ω)	(Ω)	(W)	(%)	(dB)	($^\circ$)
1805	$4.6 - j11.0$	$2.2 + j2.1$	112	66.9	19.1	-31
1842	$5.0 - j11.8$	$2.3 + j2.0$	112	68.4	19.2	-28
1880	$5.9 - j12.4$	$2.1 + j1.6$	116	67.8	19.3	-27
1930	$7.4 - j13.6$	$2.0 + j1.4$	110	67.6	19.5	-33
1960	$8.7 - j14.1$	$2.0 + j1.1$	113	66.7	19.5	-34
1990	$9.7 - j14.3$	$1.9 + j0.7$	121	65.8	19.3	-33

[1] Z_S and Z_L defined in Figure 1.

[2] At 3 dB gain compression.

[3] At $P_L = 83.2 \text{ W}$.

Table 13. Typical impedance of peak device at 1 : 1 load

Measured load-pull data (peak device); $I_{DQ} = 780 \text{ mA}$; $V_{DS} = 48 \text{ V}$; pulsed CW ($t_p = 100 \mu\text{s}$; $\delta = 10 \%$).

f	Z_S [1]	Z_L [1]	P_L [2]	η_D [2]	G_p [2]	AM/PM [2]
(MHz)	(Ω)	(Ω)	(W)	(%)	(dB)	($^\circ$)
1805	$4.8 - j8.8$	$1.6 - j1.1$	404	67.9	14.7	-11
1842	$5.6 - j9.5$	$1.6 - j1.2$	405	69.1	14.9	-12
1880	$6.8 - j9.7$	$1.6 - j1.4$	405	69.8	14.9	-12
1930	$9.3 - j8.4$	$1.5 - j1.4$	376	72.2	15.7	-13
1960	$10.3 - j7.7$	$1.5 - j1.5$	365	71.6	15.7	-13
1990	$10.9 - j6.9$	$1.5 - j1.7$	362	71.0	15.8	-15

[1] Z_S and Z_L defined in Figure 1.

[2] At 3 dB gain compression.

Table 14. Typical off-state impedance of peak device

Measured under the following conditions: $V_{DS} = 48 \text{ V}$; $V_{GS} = -5.0 \text{ V}$.

f	Z_{off}
(MHz)	(Ω)
1805	$0.2 - j1.6$
1842	$0.2 - j1.4$
1880	$0.2 - j1.2$
1930	$0.2 - j1.0$
1960	$0.2 - j0.8$
1990	$0.2 - j0.6$

7.4 Test circuit

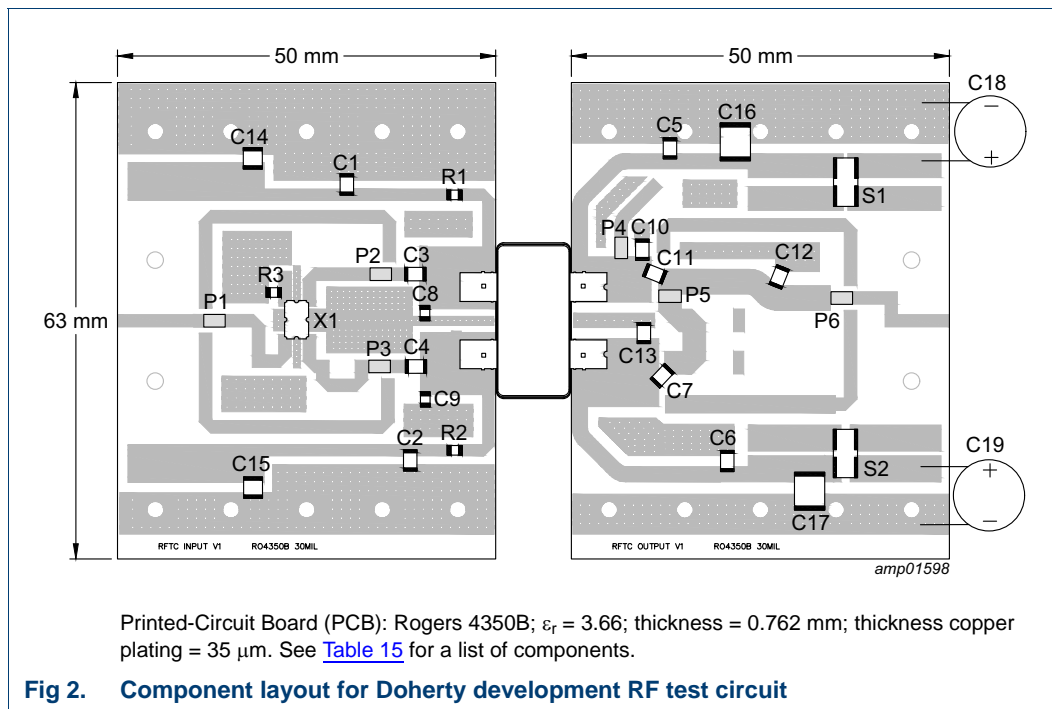


Table 15. List of components

See [Figure 2](#) for component layout.

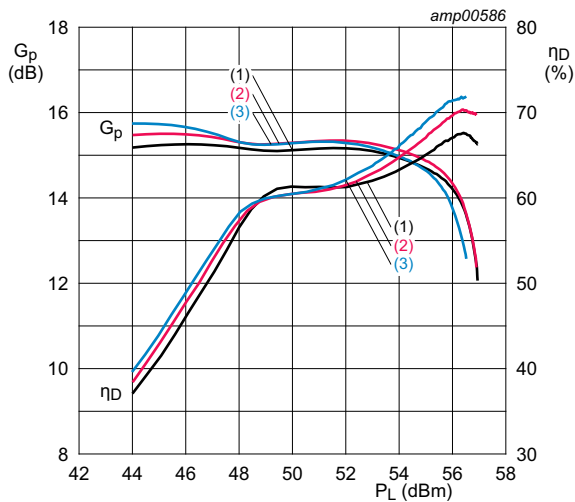
Component	Description	Value	Remarks
C1, C2, C3, C4, C5, C6, C7	multilayer ceramic chip capacitor	22 pF	ATC 800B
C8	multilayer ceramic chip capacitor	0.5 pF	ATC 600F
C9	multilayer ceramic chip capacitor	1.6 pF	ATC 600F
C10	multilayer ceramic chip capacitor	1.4 pF	ATC 800B
C11	multilayer ceramic chip capacitor	3.3 pF	ATC 800B
C12	multilayer ceramic chip capacitor	0.5 pF	ATC 800B
C13	multilayer ceramic chip capacitor	2.4 pF	ATC 800B
C14, C15	multilayer ceramic chip capacitor	1 μF , 100 V	Murata GRM31CR72A105KA01L
C16, C17	multilayer ceramic chip capacitor	10 μF , 100 V	Murata KRM55QR72A106KH01L
C18, C19	electrolytic capacitor	1000 μF , 100 V	
P1, P2, P3, P4, P5, P6	copper foil		
R1, R2	resistor	9.1 Ω	SMD 0805
R3	resistor	51 Ω	SMD 0805
S1, S2	four terminal high precision current sense resistor		Ohmite: LVK25 (1224) or of same quality
X1	hybrid coupler	2 dB, 90°	Anaren: X3C20F1-02S

7.5 Graphical data

All data are measured on the Doherty development RF test circuit.

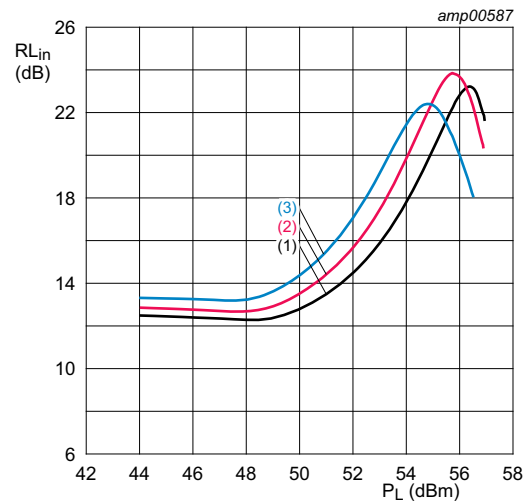
7.5.1 Pulsed CW

$t_p = 100 \mu s$; $\delta = 10 \%$; $V_{DS} = 48 V$; $I_{DQ} = 300 mA$; $V_{GS(amp)peak} = -5.0 V$.



- (1) $f = 1805 MHz$
- (2) $f = 1842 MHz$
- (3) $f = 1880 MHz$

Fig 3. Power gain and drain efficiency as function of output power; typical values

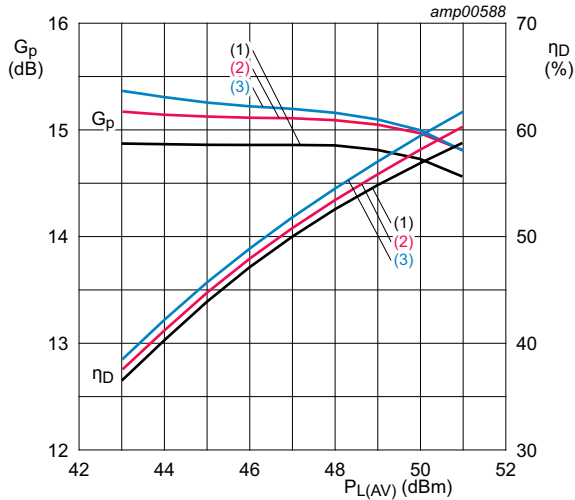


- (1) $f = 1805 MHz$
- (2) $f = 1842 MHz$
- (3) $f = 1880 MHz$

Fig 4. Input return loss as a function of output power; typical values

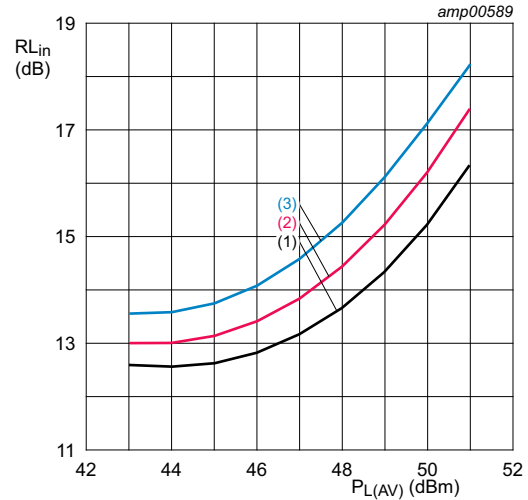
7.5.2 1-Carrier W-CDMA

PAR = 7.2 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 64 DPCH;
 $V_{DS} = 48$ V; $I_{DQ} = 300$ mA; $V_{GS(amp)peak} = -5.0$ V.



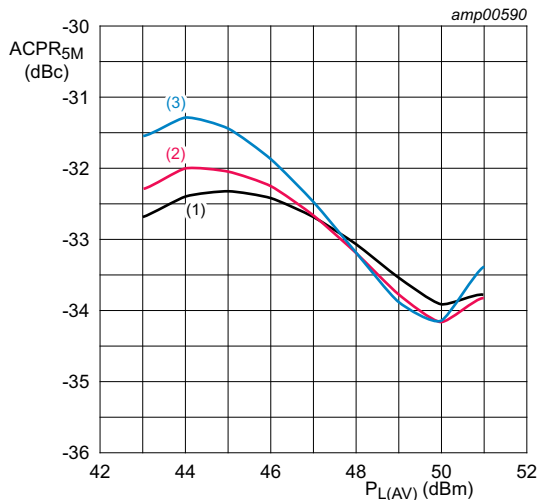
- (1) $f = 1807.5$ MHz
- (2) $f = 1842$ MHz
- (3) $f = 1877.5$ MHz

Fig 5. Power gain and drain efficiency as function of average output power; typical values



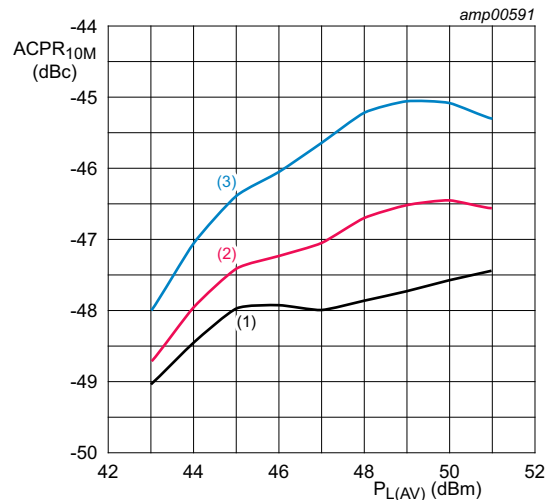
- (1) $f = 1807.5$ MHz
- (2) $f = 1842$ MHz
- (3) $f = 1877.5$ MHz

Fig 6. Input return loss as function of average output power; typical values



- (1) $f = 1807.5$ MHz
- (2) $f = 1842$ MHz
- (3) $f = 1877.5$ MHz

Fig 7. Adjacent channel power ratio (5 MHz) as a function of average output power; typical values

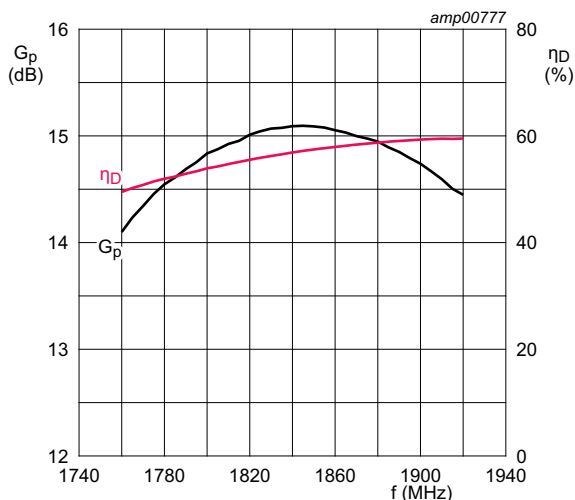


- (1) $f = 1807.5$ MHz
- (2) $f = 1842$ MHz
- (3) $f = 1877.5$ MHz

Fig 8. Adjacent channel power ratio (10 MHz) as a function of average output power; typical values

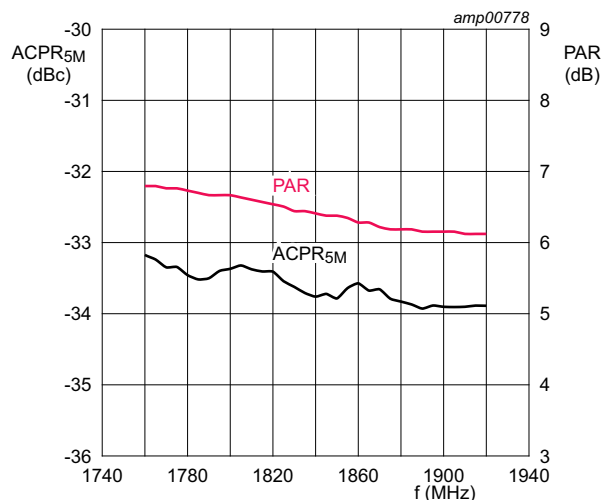
7.5.3 Broadband performance

Test signal: 1-carrier W-CDMA; PAR = 7.2 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 64 DPCH; $V_{DS} = 48$ V; $I_{Dq} = 300$ mA; $V_{GS(amp)peak} = -5.0$ V.



$P_{L(AV)} = 49.2$ dBm.

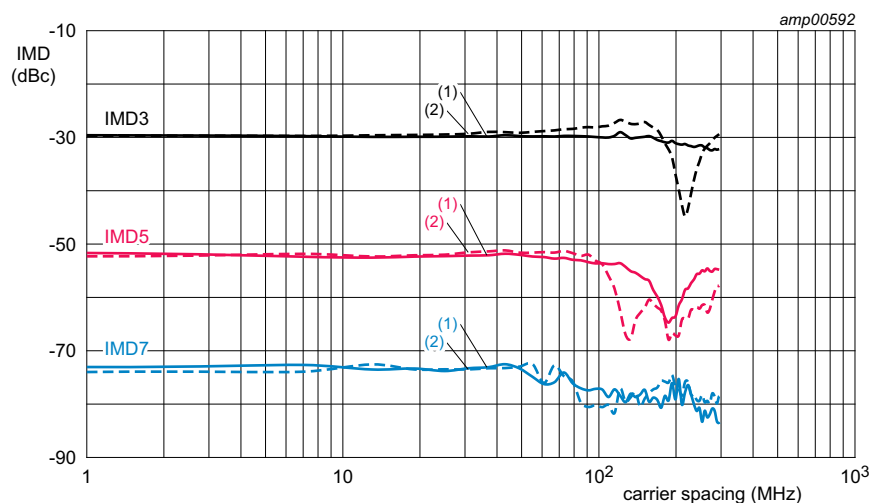
Fig 9. Power gain and drain efficiency as function of frequency; typical values



$P_{L(AV)} = 49.2$ dBm.

Fig 10. Adjacent channel power ratio (5 MHz) and peak-to-average ratio as a function of frequency; typical values

7.5.4 2-Tone VBW



$V_{DS} = 48$ V; $I_{Dq} = 300$ mA; $V_{GS(amp)peak} = -5.0$ V; $f_c = 1842$ MHz; $P_L = 27$ dBm.

- (1) IMD low
- (2) IMD high

Fig 11. VBW capability on the Doherty Development RF test circuit

8. Package outline

Air cavity plastic earless flanged package; 4 leads

SOT1273-1

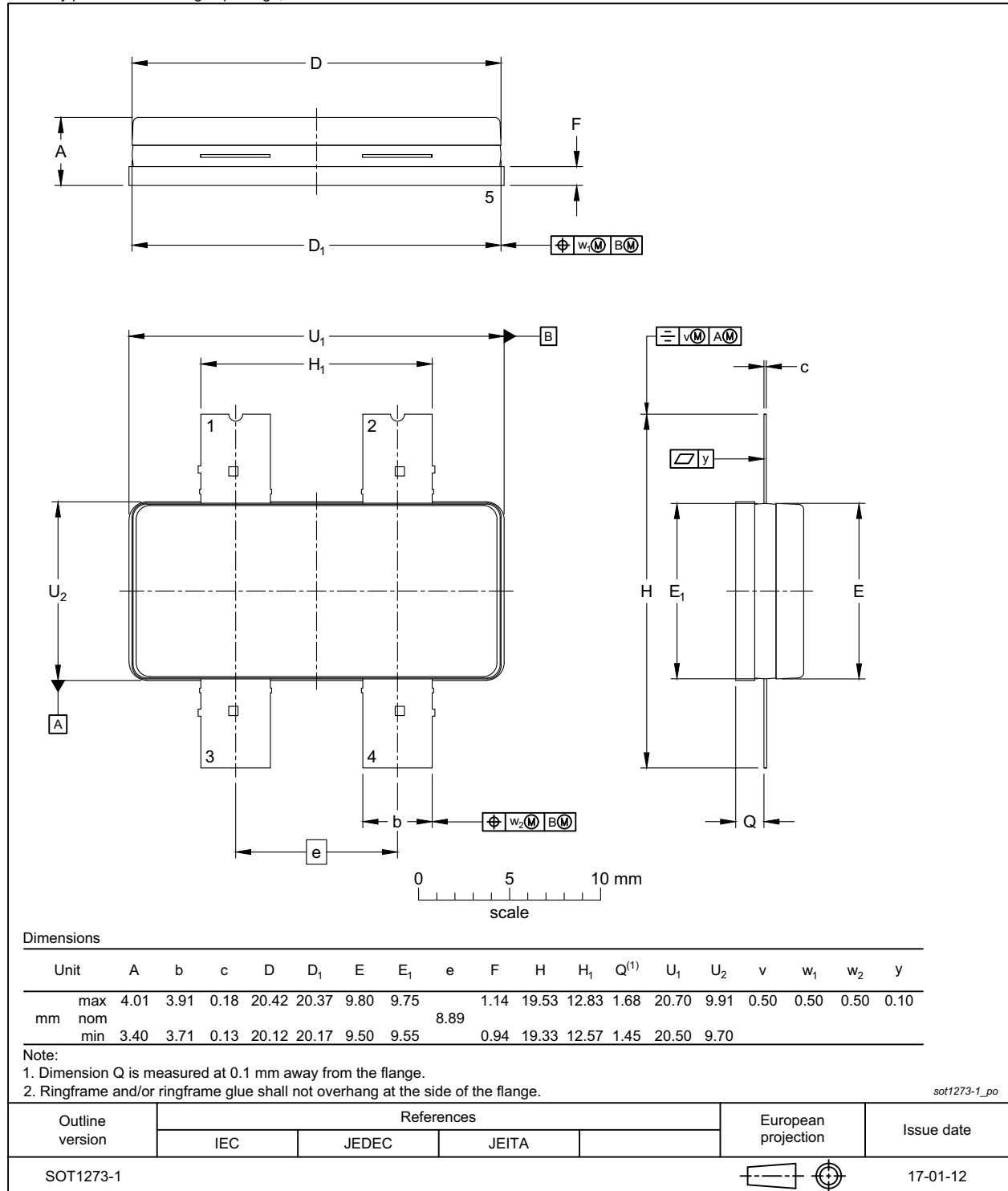


Fig 12. Package outline SOT1273-1

9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

Table 16. ESD sensitivity

ESD model	Class
Charged Device Model (CDM); According to ANSI/ESDA/JEDEC standard JS-002	C3 [1]
Human Body Model (HBM); According to ANSI/ESDA/JEDEC standard JS-001	1B [2]

[1] CDM classification C3 is granted to any part that passes after exposure to an ESD pulse of 1000 V.

[2] HBM classification 1B is granted to any part that passes after exposure to an ESD pulse of 500 V.

10. Abbreviations

Table 17. Abbreviations

Acronym	Description
3GPP	3rd Generation Partnership Project
AM	Amplitude Modulation
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
GaN	Gallium Nitride
MTF	Median Time to Failure
PAR	Peak-to-Average Ratio
PM	Phase Modulation
SMD	Surface Mounted Device
VBW	Video BandWidth
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

11. Revision history

Table 18. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
C4H18W500A v.1	20210924	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.ampleon.com>.

12.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. Ampleon does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local Ampleon sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between Ampleon and its customer, unless Ampleon and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the Ampleon product is deemed to offer functions and qualities beyond those described in the Product data sheet.

12.3 Disclaimers

Maturity — The information in this document can only be regarded as final once the relevant product(s) has passed the Release Gate in Ampleon's release process. Prior to such release this document should be regarded as a draft version.

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, Ampleon does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. Ampleon takes no responsibility for the content in this document if provided by an information source outside of Ampleon.

In no event shall Ampleon be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, Ampleon's aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of Ampleon.

Right to make changes — Ampleon reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — Ampleon products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an Ampleon product can reasonably be expected to result in personal injury, death or severe property or environmental damage. Ampleon and its suppliers accept no liability for inclusion and/or use of Ampleon products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. Ampleon makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using Ampleon products, and Ampleon accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the Ampleon product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

Ampleon does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using Ampleon products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). Ampleon does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — Ampleon products are sold subject to the general terms and conditions of commercial sale, as published at <http://www.ampleon.com/terms>, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. Ampleon hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of Ampleon products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific Ampleon product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. Ampleon accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without Ampleon's warranty of the product for such

automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond Ampleon's specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies Ampleon for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond Ampleon's standard warranty and Ampleon's product specifications.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

12.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

13. Contact information

For more information, please visit: <http://www.ampleon.com>

For sales office addresses, please visit: <http://www.ampleon.com/sales>

14. Contents

1	Product profile	1
1.1	General description	1
1.2	Features and benefits	1
1.3	Applications	1
2	Pinning information	2
3	Ordering information	2
4	Limiting values	2
5	Thermal characteristics	3
6	Characteristics	3
7	Test information	4
7.1	Ruggedness in Doherty operation	4
7.2	Impedance information	4
7.3	Recommended impedances for Doherty design	5
7.4	Test circuit	7
7.5	Graphical data	8
7.5.1	Pulsed CW	8
7.5.2	1-Carrier W-CDMA	9
7.5.3	Broadband performance	10
7.5.4	2-Tone VBW	10
8	Package outline	11
9	Handling information	12
10	Abbreviations	12
11	Revision history	12
12	Legal information	13
12.1	Data sheet status	13
12.2	Definitions	13
12.3	Disclaimers	13
12.4	Trademarks	14
13	Contact information	14
14	Contents	15

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© Ampleon Netherlands B.V. 2021.

All rights reserved.

For more information, please visit: <http://www.ampleon.com>

For sales office addresses, please visit: <http://www.ampleon.com/sales>

Date of release: 24 September 2021

Document identifier: C4H18W500A